NSN 6625-00-103-2679 Semiconductor Device Test Set - Page 1 of 1



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Shelf Life:
N/a
Unit Of Measure:
1 ea
Demilitarization:
No Fiig:
T228-a
Hazmat:
Yes
Repairability:
When repair is beyond lower level maintenance capability, evacuate the item to depot. disposal is not authorized below wholesale level.